Search Notes



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KOYAMA ET AL.

Examiner

Haidung D Nguyen

Art Unit

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SEARCHED

Class	Subclass	Date	Examiner
428	690	3/24/09	\HN\
257	40	3/24/09	\HN\
525	410, 417	3/24/09	\HN\

SEARCH NOTES

Search Notes	Date	Examiner
inventor search in eDan and Palm	3/24/09	\HN\
East search	3/24/09	\HN\

INTERFERENCE SEARCH

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